

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10540501	HAMEAU ET AL.
	Examiner Chen, Shin-Hon	Art Unit 2131

SEARCHED

Class	Subclass	Date	Examiner
713	190,193,194,300, 322	1/4/08	S.C.

SEARCH NOTES

Search Notes	Date	Examiner
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search- see search history)	1/4/08	S.C.
NPL search (google)	1/4/08	S.C.

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner